



Simulation Effect of Ga_2O_3 layer thickness on CdTe solar cell by SCAPS-1D.

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ABSTRACT

The effect of Ga_2O_3 thickness on CdTe cells was studied using the SCAPS-1D simulator. The best solar cell efficiency (14.65%) was found at the thickness of the gallium oxide layer (1-10nm) and the cell efficiency (η) decrease with an increase in the thickness of the oxide layer and the decrease of the fill factor, thus decreasing the voltage current (I-V) and decreasing the current of the short circuit (I_{sc}). The value of the open circuit voltage (V_{oc}) is approximately constant and at 0.76V. The optical properties of the cell of quantitative efficiency are 86% and decrease within 18nm.

1- Introduction

A solar cell is a photovoltaic device made of a semiconductor material that converts sunlight into a direct current. In recent years, the study of binary compounds has increased in order to create new materials for solar cells. The researches has focused on thin-film solar cells for high efficiency at relatively low cost. Thin films made of column elements II-VI have been used in the periodic table in many semiconductor devices. In the periodic table, CdTe was one of the most promising materials in the production of thin films used in solar cells due to the energy gap of the solar cells. The CdTe solar cells are the most common kinds that dating to the 1952s and contain an ideal energy gap (1.45eV) for distribution of photon within the solar spectrum and high absorption coefficient ($5 \times 10^5 \text{ cm}^{-1}$) [1,2]. The efficiency of the cell in the 1990s reached 10% and researchers hope that the efficiency will reach 20%. Ga_2O_3 is a buffer due to the high band gap (4.7eV). It is a type n, which has been known for several decades. However, it has been increasingly used lately in the crystalline structure, which tends to be standard structure of semiconductors. It is similar to In_2O_3 and Al_2O_3 , the GaN family and is used in the heterojunction system as well as homojunction. (a Solar cell capacitance simulator) SCAPS-1D

simulation program, a one-dimensional solar cell simulator program designed by the University of Gent [3] in Belgium, the original program for family structures (GaAs, Si) as well as non-crystalline ones. The objective of the study is to test the effect of Ga_2O_3 thickness on the performance of the CdTe solar cell and the study of both open-circuit voltages (V_{oc}) Short circuit current (I_{sc}), fill factor (FF), cell efficiency (η).

2. Theoretical model

The SCAPS-1D (a solar cell capacitance simulator) is one dimensional solar cell simulation program can solve basic semiconductor equations such as continuity equation, Poisson equation, carrier density, generation process, and recombination where the continuity equation for holes $\frac{\partial p(x)}{\partial t}$ and electrons $\frac{\partial n(x)}{\partial t}$ is given as follows: [4]

$$\frac{\partial n(x)}{\partial t} = G_n(x) - R_n(x) \dots (1)$$

where G_n represents the generation process for electrons and R_n represents the recombination rate. The continues equation for holes given by the equation:

$$\frac{\partial p(x)}{\partial t} = G_p(x) - R_p(x) \dots (2)$$

where G_p represents the generation process for holes and R_p represents the recombination rate. The charge density (ρ) the potential (Φ) and electron permittivity (ϵ) are related to the Poisson equation and the following formula [4]:

$$\frac{d \ln(\epsilon(x))}{dx} \cdot \frac{d\Phi(x)}{dx} + \frac{d^2\Phi}{dx^2} = -\frac{\rho(x)}{\epsilon(x)} \dots (4)$$

If ϵ is constant, the Poisson equation is in the following formula:

$$\frac{d^2\Phi}{dx^2} = -\frac{\rho(x)}{\epsilon} \dots (6)$$

The current passing through the solar cell is as follows: [5]

$$I = I_0 \left(\exp \frac{qv}{kT} - 1 \right) - I_l \dots (7)$$

Where I is the current of the load, I_l is the photocurrent, I_0 Reverse saturation current, T the absolute temperature, K is the Boltzmann constant and v the load voltage which is equal to zero when the load resistance is zero, the current passing is the short circuit current, when the voltages equal zero, equation 7 becomes the following formula: [5]

$$I_{sc} = -I_l \dots (8)$$

Short circuit current (I_{sc}) In the case of the open circuit voltage, the resistance is large as possible and the current is zero [5]

$$V_{oc} = \frac{kT}{q} \ln \left(\frac{I_{sc}}{I_0} + 1 \right) \dots (9)$$

where V_{oc} is the open circuit voltage, the fill factor is a measure of the reference range of the output properties and its value for the cells with acceptable efficiency between (70 -85) % and is defined according to the following relationship: [5]

$$FF = \frac{V_m I_m}{V_{oc} I_{sc}} \dots (10)$$

where V_m and I_m are the maximum of the voltage and current respectively, the efficiency of solar cell can be write as [5]:

$$\eta = \frac{\text{output power}(P_m)}{\text{input power}(P_{in})} \times 100\%$$

$$\eta = \frac{I_m V_m}{P_{in}} \times 100\% \dots (11)$$

Thus, equation (11) can be write as:

$$\eta = \frac{FF \times I_{sc} \times V_{oc}}{P_{in}} \times 100\% \dots (12)$$

3- Cell description

The solar cell we have studied is composed of (TCO / Ga_2O_3 / CdTe). The TCO represents the transparent metal oxides made from ZnO and has a higher transparency (85%) at wavelength (550nm) [2]. Gallium oxide is a substance high energy gap (4.7ev) and called a buffer layer [6]. CdTe is a semiconductor material with a band gap (1.45ev) as illustrated in fig (1). The defect for CdTe is an acceptor and for Ga_2O_3 a donor as shown in the table (1). Some defects create their own energy levels in the band gap of semiconductor [7], which results in formation of *trapping centers* for charge carriers (electrons and holes). When the charge carriers capture on such centers, they either loose time before reaching the edge of semiconductor edges, or vanish due to recombination.

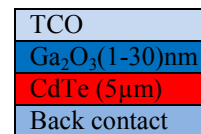


Fig. 1: Installation of solar cell used in research

Table 1: shows the solar cell parameters used in the study [8]

Properties	n-Ga2O3	p-CdTe
Thickness	1-30)nm(5μm
Band gap	4.8 eV	1.45 Ev
electron affinity (eV)	3.5	4.3
Dielectric permittivity	9.93	9.4
CB effective density of states (1/cm ³)	2.2x10 ¹⁸	1.3x10 ¹⁹
VB effective density of states (1/cm ³)	1.8x10 ¹⁹	7.6x10 ¹⁸
electron thermal velocity (cm/s)	1x10 ⁷	1x10 ⁷
hole thermal velocity (cm/s)	1x 10 ⁷	1x10 ⁷
electron mobility (cm ² /Vs)	10	50
hole mobility (cm ² /Vs)	10	30
shallow uniform donor density ND (1/cm ³)	2x 10 ¹⁷	0
shallow uniform acceptor density NA (1/cm ³)	10	1x10 ¹³
T(k)	300	300
Rs (Ω.cm ²)	0.1	0.1
Defect type	Donor[8]	Acceptor[7]
energetic distribution	Single	Single
Nt total (1/cm ³)	1x10 ¹⁴	1x10 ¹⁴
Capture cross section electrons (cm ²)	1x10 ⁻¹⁵	1x10 ⁻¹⁸
Capture cross section hole (cm ²)	1x10 ⁻¹²	1x10 ⁻¹⁶

4-Results and discussion

4-1 Effect of Ga_2O_3 on I-V Properties

Photocurrent is one of the most important parameters affecting the efficiency of the solar cell. The general formula of these curves is a rise in the value of the current with increasing width of the depletion region, which increases built in potential. Thus, the probability of electron-holes separating is increased and reduces the recombination process on the

interface, which increases the photocurrent [9]. When the thickness (5,10) nm of the recombination on the interface is very weak, the effect of the Ga_2O_3 on the I-V properties causing a reduction in the voltage-current curve with increase in the thickness of the buffer layer. We studied a voltage current at the thickness of (5,10,15,20,25,30) nm as Shown in figure (2A).

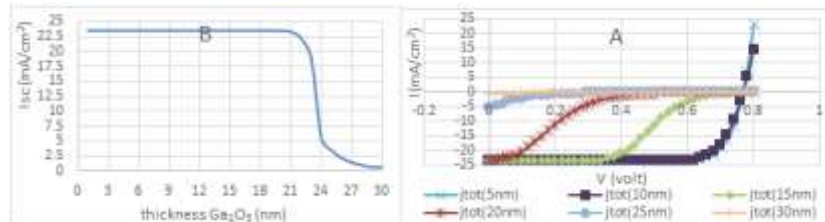


Fig. 2: Effect of Ga_2O_3 layer thickness on A(I-V) curve, B -Short Circuit Current (J_{sc})

The decrease in(I-V) curve is with on increase in the thickness is due to reduction in photo current. Increasing the thickness increases the process of the recombination on the interface [5], so that the rate of generation of electron-hole will be pair reducing short current (J_{sc}), because formation of trapping centers Which works to depletion the minority carriers [10]. figure (2B) shows the effect of Ga_2O_3 on the short circuit current. According to Figure (2B), there are three regions first, where the thickness of the oxide layer is about 21 nm and J_{sc} is almost constant at

23.5mA/cm², the second is where the current is grading and the third region where the recombination current is dominant due to the recombination process on the interface, From the voltage-current curve, we observe decline the area between the voltage current in the fourth quarter and decreasing the fill factor.

The photovoltaic cell is as good as the fill factor about one, the effect of oxide thickness on fill factor illustrated in figure (3A). In this figure, we find three regions , the first region (1-10nm), where

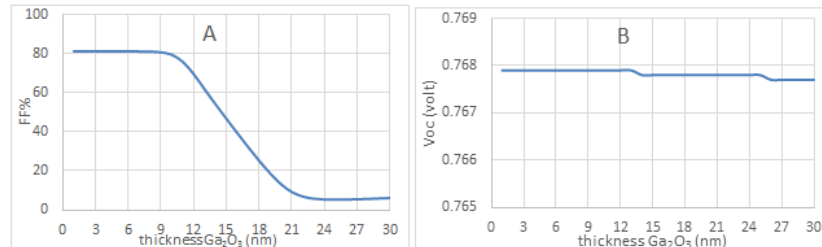


Fig. 3: Effect of Ga_2O_3 on the. A (Fill Factor (FF)). B (voltage open circuit(V_{oc})).

the fill factor reaches 82% and don't exceed 85% because the absorbance of TCO layer [11]. The second region, when the thickness of (10-23) nm shows a linear decline, until (78%) at the thickness of (10nm) and reach (5%) at the thickness of (23nm) because recombination at interface, thus causing to capture electrons and reduce the current [12]. While the third region at (23nm) and above, the fill factor is reduced to its lowest value. This is due to the fact that the fill factor is affected by increasing the series resistance [12]. The higher thickness of the gallium oxide, lead to higher of the series resistance and the decreasing in fill factor. The effect of gallium oxide on open voltage circuit is slight. The increase in the thickness of the gallium oxide leads to a reduction in the photocurrent, which is linearly linked to the voltage open circuit, resulting in lower open circuit voltages but slightly [10]as show in figure (3B).

The efficiency of the solar cell is defined as the ratio between the output power of the solar cell and the power incident on it. As the increase in the thickness of the gallium oxide layer has a negative effect on each of the above electrical properties. The increase of the thickness decreases the short circuit current (J_{sc}), the open voltage circuit (V_{oc}) Fill Factor and efficiency of the cell decreases with increasing the thickness of the gallium oxide, as shown in figure (4). We find that the efficiency of the solar cell is constant with the increase of thickness up to (9nm) and then decreases with the increase of thickness above the that because the density of electrons is high within this range and then show linear decrease with thickness due to centers of the recombination at the interface, which affects the value of efficiency.

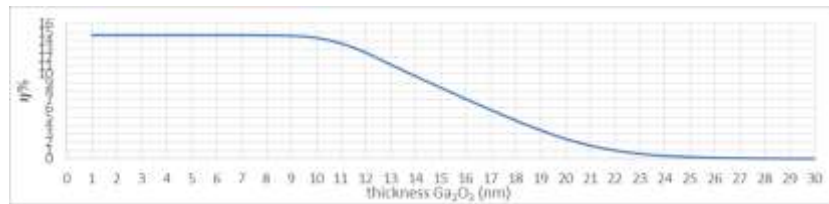


Fig. 4: shows the effect of Ga_2O_3 on cell efficiency (η)

4.1.2 Effect of Ga_2O_3 on C-V Properties and band diagram

The characteristics of the C-V are important electrical properties that calculate the width of depletion (V_{bi}) determine the type of junction whether it is Abrupt or Graded. Increasing the thickness increases the value of the capacitance and therefore reduce the amount of depletion layer as in the figure (5A). As the increase in fish work to change the difference among Fermi level and the level (E_n) conduction band (E_c) and Fermi level (E_p) and level band (E_v), which increases

the process of depletion as in figure (6) (A,B,C,D,E,F). It is noted that the oxide region is completely depleted, especially with positive voltages. In the negative voltages, the total depletion region is shown in CdTe and the relationship between the capacitance and the depletion area as follows: [13,14]

$$C = \frac{dQ}{dV} = \frac{\epsilon_s}{\omega} \dots (13)$$
 Where dQ changes the charge of the depletion layer, dV the applied voltage ω width of the depletion region and as in figure (5B)

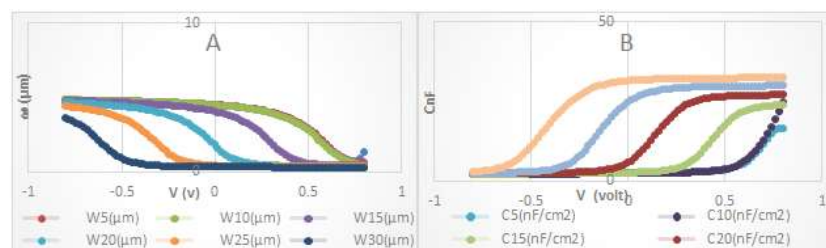


Fig. 5: Effect of the thickness of the Ga_2O_3 layer on the. A (depletion layer (W)).B(C-V Properties)

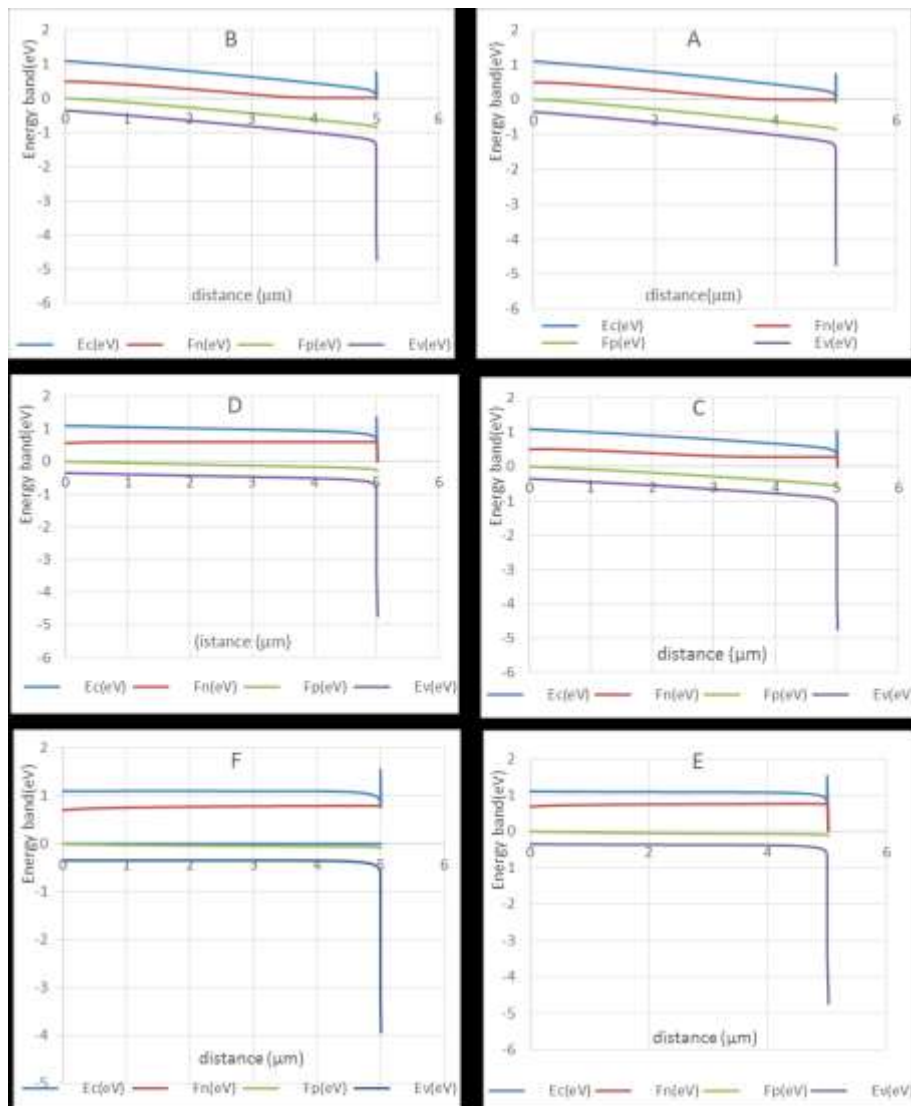


fig. 6: Effect of the thickness of the Ga_2O_3 oxide layer (A=5nm, B=10nm, C=15nm, D=20nm, E=25nm, F=30nm) on the Energy band.

The figure (7) shows a larger part of the previous Fermi level and increases the capacity of the cell forms. The increase in thickness shows the high of

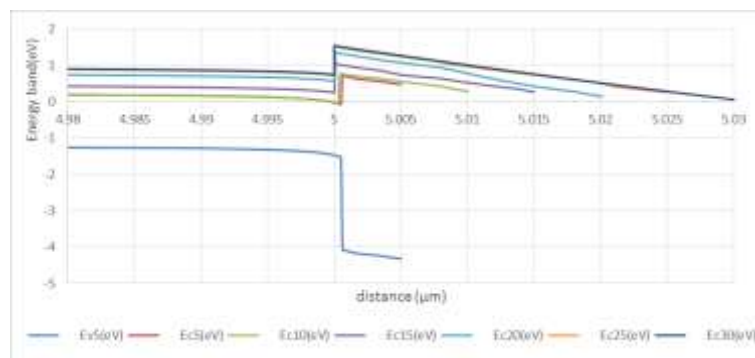


Fig. 7: Larger shape of energy band

4.1.3 Effect of Ga_2O_3 on Quantum Efficiency (QE)

Quantum efficiency is an important optical factor in solar cells, and QE is defined as the number of electron-hole pairs generated by incident photon [15]. The increase of Ga_2O_3 thickness layer increase affects the performance of the solar cell and thus affects

absorption cell and reduce the efficiency of the solar cell see figure (8). The highest value of the quantitative efficiency is about (85%), Within the wavelength (300-825) nm at thickness (1-18) nm and then the quantum efficiency decreases because the increase in the absorption of photons from the Ga_2O_3

oxide layer, which reduces the rate of generating pairs, which affects the value of quantum efficiency [16]. At wave length greater them $\lambda=825\text{nm}$ where

the process of absorption of cadmium Telluride (CdTe) occurs as shown in figure (8) .

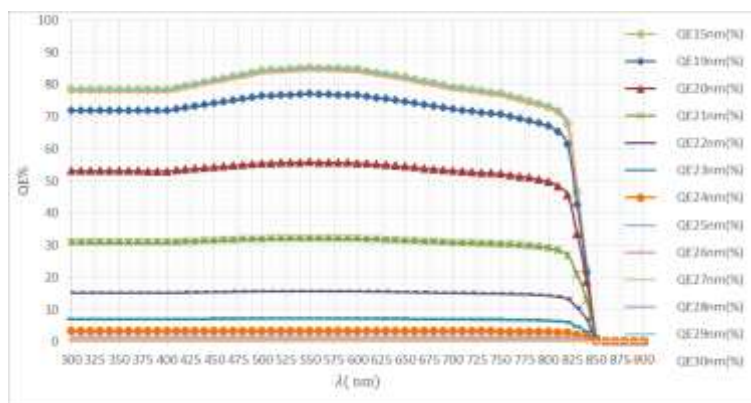


Fig.8: Effect of (Ga_2O_3) on Quantitative Efficiency (QE%)

Figure 9 shows that the best thickness of gallium oxide is about (1-18) nm, which has a high quantum

efficiency at wavelength (550nm).

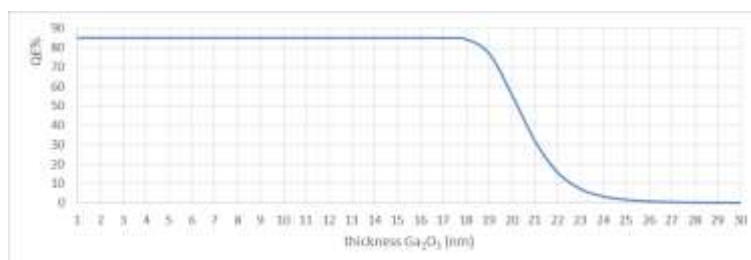


Fig. 9: Effect of Ga_2O_3 Thickness on Quantum Efficiency at Wavelength (550nm)

5. Conclusions

we have found that increasing the thickness of the buffer layer significantly affect the properties of the current - voltage because of the recombination increased at the interface. The best thickness of the buffer layer is up to (1-10) nm and increase the thickness are very effective on short circuit, fill factor as well as the impact of the efficiency of the cell.

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Increasing the thickness of the oxide layer affects the properties of the capacitance – voltage and Increasing the thickness of the oxide layer reduces the depletion layer, which increases the capacitance of the cell. The optical properties found that increasing the thickness of the oxide layer works to reduce the absorption of incident photons and thus reduce the quantum efficiency.

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محاكاة تأثير سمك طبقة أوكسيد الكالسيوم الثلاثي على خلايا تيلورايد كادميوم الشمسية باستخدام

سكابس - ببعد واحد

عدنان علوان محمد عبدالله ، عايد نجم صالح

قسم الفيزياء ، كلية التربية للعلوم الصرفة ، جامعة تكريت ، تكريت ، العراق

الملخص

تم دراسة تأثير سمك طبقة الحاجز Ga₂O₃ على خلايا تيلورايد الكادميوم CdTe باستخدام محاكي SCAPS-1D وجد ان أفضل كفاءة للخلية الشمسية (14.65%) عند سمك طبقة أوكسيد الجاليوم تتراوح (1-10nm) ثم تبدى كفاءة الخلية (η) بالانخفاض مع زيادة سمك طبقة الاوكسيد وانخفاض عامل المليء (Fill Factor) وبذلك ينخفض منحنى تيار - جهد (I-V) ويقل بذلك تيار الدائرة القصيرة (I_{sc}) . اما قيمة فولتية الدائرة المفتوحة (V_{oc}) ثابتة تقريبا وبحدود (0.76V). اما الخواص البصرية للخلية المتمثلة بالكفاءة الكمية تكون قيمتها (86%) وتنخفض ضمن سمك (18nm).